



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts,Customers Priority,Honest Operation,and Considerate Service",our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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**IGBT/SiC Diode Co-pack**

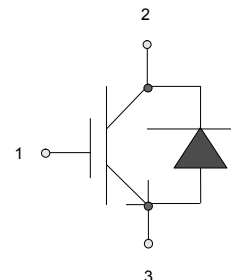
$V_{CES}$	=	1200 V
$I_{CM}$	=	35 A
$V_{CE(SAT)}$	=	3.0 V

**Features**

- Optimal Punch Through (OPT) technology
- SiC freewheeling diode
- Positive temperature coefficient for easy paralleling
- Extremely fast switching speeds
- Temperature independent switching behavior of SiC rectifier
- Best RBSOA/SCSOA capability in the industry
- High junction temperature
- Industry standard packaging

**Package**

- RoHS Compliant


**TO – 247AB**
**Advantages**

- Industry's highest switching speeds
- High temperature operation
- Improved circuit efficiency
- Low switching losses

**Applications**

- Solar Inverters
- Aerospace Actuators
- Server Power Supplies
- Resonant Inverters > 100 kHz
- Inductive Heating
- Electronic Welders

**Maximum Ratings, at  $T_j = 150\text{ }^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Values	Unit
<b>IGBT</b>				
Collector-Emitter Voltage	$V_{CES}$		1200	V
DC-Collector Current	$I_{CM}$	$T_c \leq 105\text{ }^\circ\text{C}$	35	A
Gate Emitter Peak Voltage	$V_{GES}$		$\pm 20$	V
Operating Temperature	$T_{vj}$		-40 to +150	$^\circ\text{C}$
Storage Temperature	$T_{stg}$		-40 to +150	$^\circ\text{C}$
<b>Free-wheeling diode</b>				
DC-Forward Current	$I_F$	$T_c \leq 105\text{ }^\circ\text{C}$	35	A
Non Repetitive Peak Forward Current	$I_{FM}$	$T_c = 25\text{ }^\circ\text{C}$ , $t_p = 10\text{ }\mu\text{s}$	tbd	A
Surge Non Repetitive Forward Current	$I_{F,SM}$	$t_p = 10\text{ ms}$ , half sine, $T_c = 25\text{ }^\circ\text{C}$	tbd	A

**Thermal Characteristics**

Th. Resistance Junction to Case	$R_{thJC}$	IGBT	0.34	K/W
Th. Resistance Junction to Case	$R_{thJC}$	SiC diode	0.31	K/W

**Mechanical Properties**

Mounting Torque	$M_d$	Values		
		min.	typ.	max.
		1.5		2

<http://www.genesicsemi.com/index.php/sic-products/copack>

**Electrical Characteristics**

Parameter	Symbol	Conditions	Values			Unit	
			min.	typ.	max.		
<b>IGBT</b>							
Gate Threshold Voltage	$V_{GE(th)}$	$V_{GE} = V_{GE}^*$ , $I_C = 0.6 \text{ mA}$ , $T_J = 25^\circ\text{C}$	5.5	6	6.5	V	
Collector-Emitter Leakage Current	$I_{CES,25}$	$V_{GE} = 0 \text{ V}$ , $V_{CE} = V_{CES}^*$ , $T_J = 25^\circ\text{C}$		0.02	0.2	mA	
	$I_{CES,150}$	$V_{GE} = 0 \text{ V}$ , $V_{CE} = V_{CES}^*$ , $T_J = 150^\circ\text{C}$		0.3		mA	
Gate-Leakage Current	$I_{GES}$	$V_{CE} = 0 \text{ V}$ , $V_{GE} = 20 \text{ V}$ , $T_J = 25^\circ\text{C}$			500	nA	
Collector-Emitter Threshold Voltage	$V_{CE(TO)}$	$T_J = 25^\circ\text{C}$		1.1		V	
Collector-Emitter Slope Resistance	$R_{CE,25}$	$V_{GE} = 15 \text{ V}$ , $T_J = 25^\circ\text{C}$		50		m $\Omega$	
	$R_{CE,150}$	$V_{GE} = 15 \text{ V}$ , $T_J = 150^\circ\text{C}$		87.5		m $\Omega$	
Collector-Emitter Saturation Voltage	$V_{CE(SAT)}$	$I_C = 35 \text{ A}$ , $V_{GE} = 15 \text{ V}$ , $T_J = 25^\circ\text{C}(150^\circ\text{C})$		3.0(3.9)		V	
Input Capacitance	$C_{ies}$	$V_{GE} = 0 \text{ V}$ , $V_{CE} = 25 \text{ V}$ , $f = 1 \text{ MHz}$		tbid		nF	
Output Capacitance	$C_{oes}$				tbid		nF
Reverse Transfer Capacitance	$C_{res}$				tbid		nF
Gate Charge	$Q_g$	$V_{CC} = 800 \text{ V}$ , $I_C = 35 \text{ A}$ , $V_{GE} = 15 \text{ V}$		50		nC	
Reverse Bias Safe Operating Area	RBSOA	$T_J = 125^\circ\text{C}$ , $R_g = 56\Omega$ , $V_{CC} = 1200 \text{ V}$ , $V_{GE} = 15 \text{ V}$		45		A	
Short Circuit Current	$I_{sc}$	$T_J = 125^\circ\text{C}$ , $R_g = 56\Omega$ , $V_{CC} = 900 \text{ V}$ , $V_{GE} = \pm 15 \text{ V}$		60		A	
Short Circuit Duration	$t_{sc}$				10		$\mu\text{s}$
Rise Time	$t_r$	$V_{CC} = 800 \text{ V}$ , $I_C = 35 \text{ A}$ , $R_{gon} = R_{goff} = 22 \Omega$ , $V_{GE(on)} = 15 \text{ V}$ , $V_{GE(off)} = -8 \text{ V}$ , $T_J = 125^\circ\text{C}$		85		ns	
Fall Time	$t_f$			205		ns	
Turn On Delay Time	$t_{d(on)}$			40		ns	
Turn Off Delay Time	$t_{d(off)}$			232		ns	
Turn-On Energy Loss Per Pulse	$E_{on}$			2.66		mJ	
Turn-Off Energy Loss Per Pulse	$E_{off}$		4.35		mJ		
<b>Free-wheeling diode</b>							
Forward Voltage	$V_F$	$I_F = 35 \text{ A}$ , $V_{GE} = 0 \text{ V}$ , $T_J = 25^\circ\text{C} (150^\circ\text{C})$		2.6(3.5)		V	
Threshold Voltage at Diode	$V_{D(TO)}$	$T_J = 25^\circ\text{C}$		0.8		V	
Peak Reverse Recovery Current	$I_{rrm}$	$I_F = 35 \text{ A}$ , $V_{GE} = 0 \text{ V}$ , $V_R = 650 \text{ V}$ $-di_F/dt = 300 \text{ A}/\mu\text{s}$ , $T_J = 125^\circ\text{C}$		3.01		A	
Reverse Recovery Time	$t_{rr}$				36		ns
Diode peak rate of fall of reverse recovery current during tb	$di_{rr}/dt$				190		A/ $\mu\text{s}$

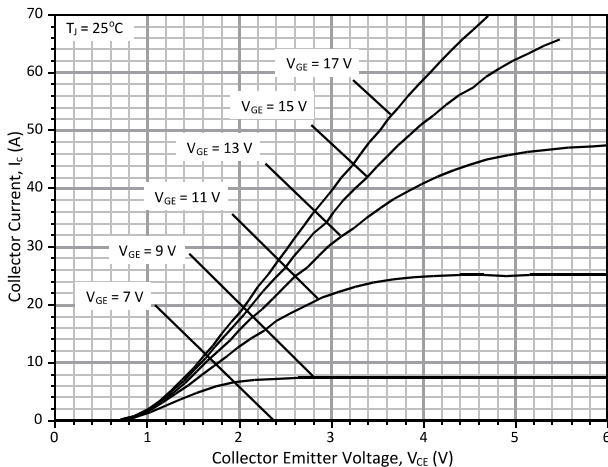


Figure 1: Typical Output Characteristics at 25 °C

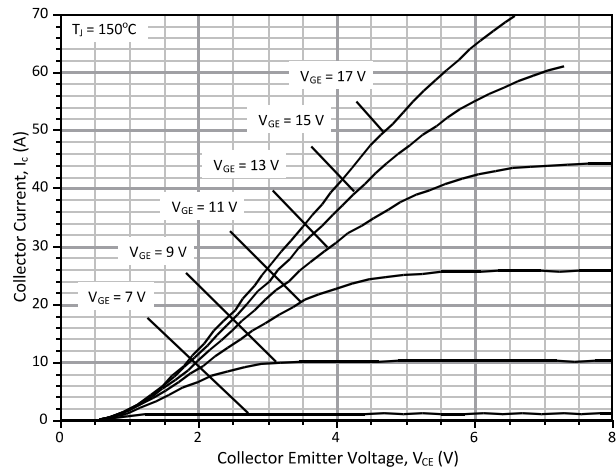


Figure 2: Typical Output Characteristics at 150 °C

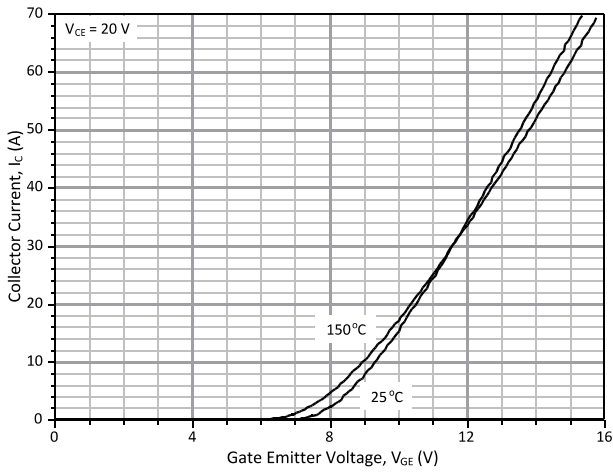


Figure 3: Typical Transfer Characteristics

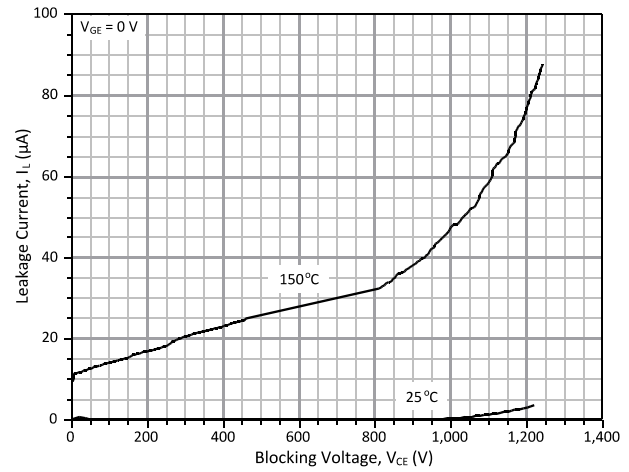


Figure 4: Typical Blocking Characteristics

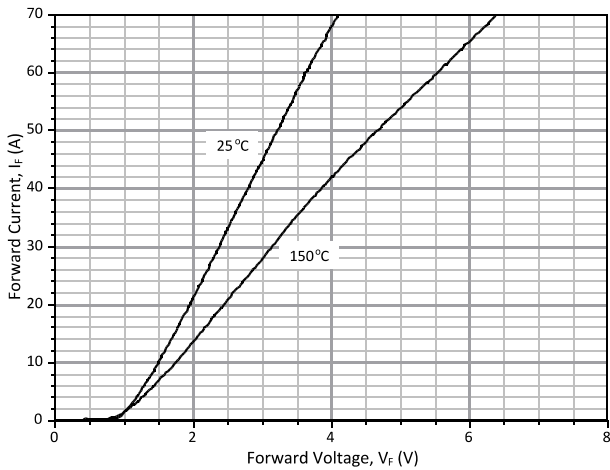


Figure 5: Typical FWD Forward Characteristics

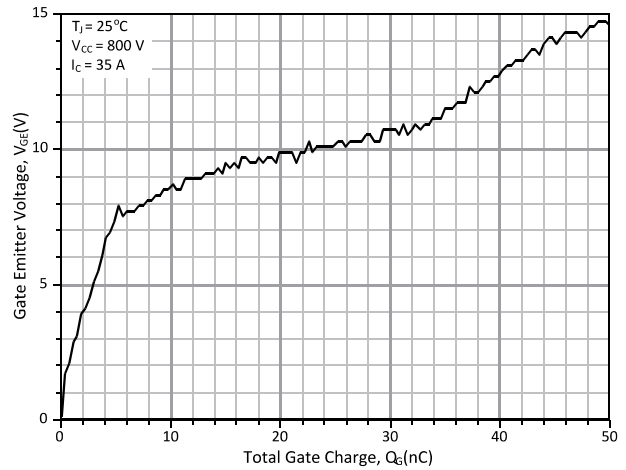


Figure 6: Typical Turn On Gate Charge

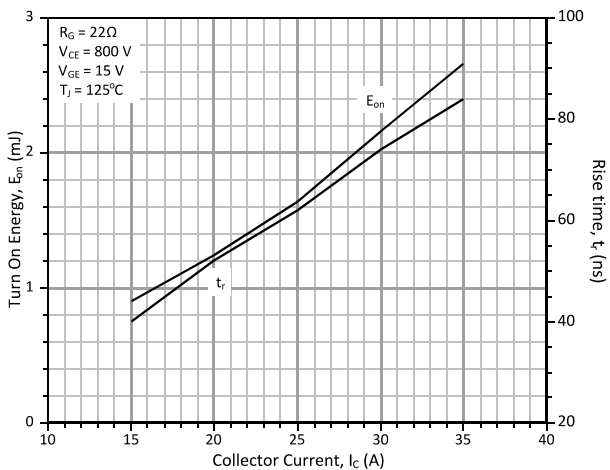


Figure 7: Typical Turn On Energy Losses and Switching Times

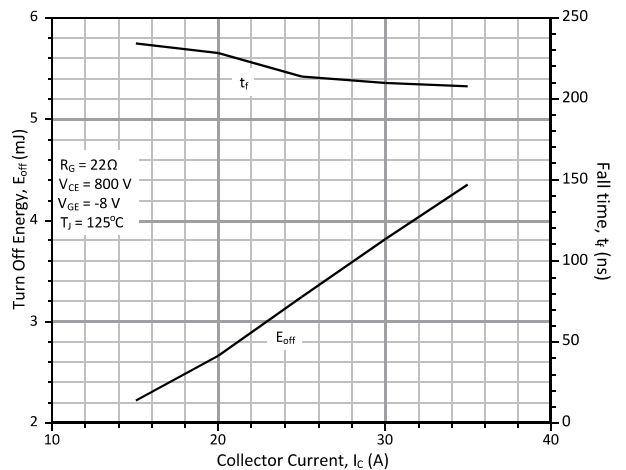


Figure 8: Typical Turn Off Energy Losses and Switching Times



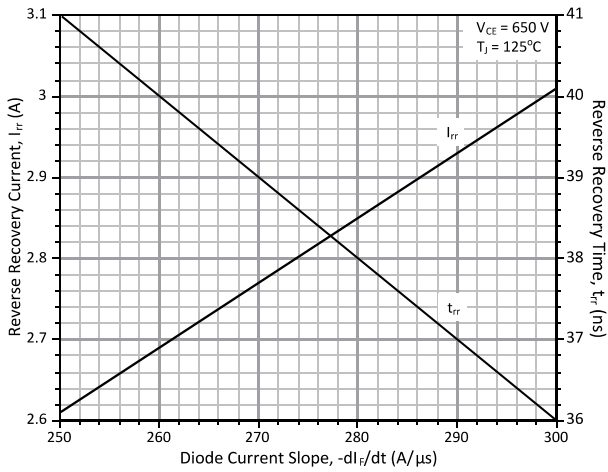
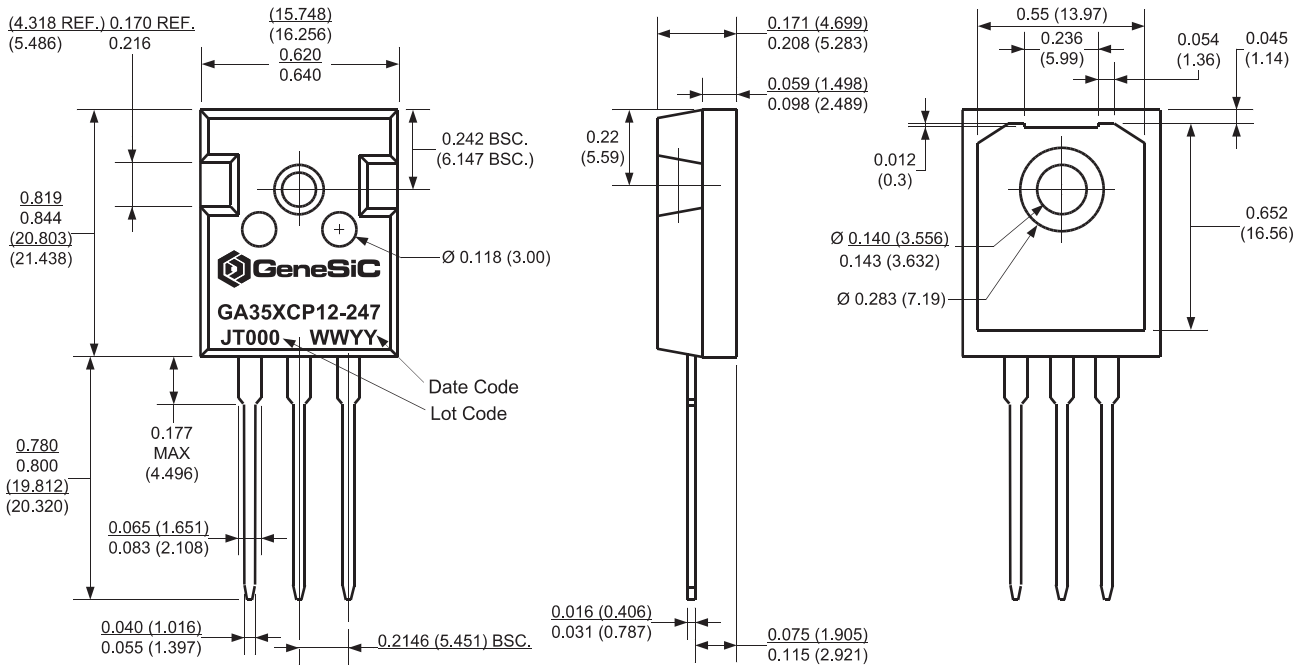


Figure 9: Typical Reverse Recovery Currents and Times

**Package Dimensions:**

**TO-247AB**

**PACKAGE OUTLINE**



**NOTE**

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

**Revision History**

Date	Revision	Comments	Supersedes
2011/01/06	1	First generation release	

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